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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/829,392	04/22/2004	Hermann Wagner	KEKO-0002	5417
23599	7590 06/22/2006		EXAMINER	
•	VHITE, ZELANO & BR. ENDON BLVD.	GEORGE, PA	GEORGE, PATRICIA ANN	
SUITE 1400 ARLINGTON, VA 22201			ART UNIT	PAPER NUMBER
			1765	
			DATE MAILED: 06/22/2006	

Please find below and/or attached an Office communication concerning this application or proceeding.

	Application No.	Applicant(s)			
•	10/829,392	WAGNER ET AL.			
Office Action Summary	Examiner	Art Unit			
	Patricia A. George	1765			
The MAILING DATE of this communication appears on the cover sheet with the correspondence address Period for Reply					
A SHORTENED STATUTORY PERIOD FOR REPLY WHICHEVER IS LONGER, FROM THE MAILING DA - Extensions of time may be available under the provisions of 37 CFR 1.13 after SIX (6) MONTHS from the mailing date of this communication. - If NO period for reply is specified above, the maximum statutory period was railure to reply within the set or extended period for reply will, by statute, Any reply received by the Office later than three months after the mailing earned patent term adjustment. See 37 CFR 1.704(b).	ATE OF THIS COMMUNICATION 36(a). In no event, however, may a reply be tim rill apply and will expire SIX (6) MONTHS from to cause the application to become ABANDONEI	N. nely filed the mailing date of this communication. D (35 U.S.C. § 133).			
Status					
Responsive to communication(s) filed on 31 M. This action is FINAL. 2b) ☑ This Since this application is in condition for allowar closed in accordance with the practice under E.	action is non-final. nce except for formal matters, pro				
Disposition of Claims					
4) Claim(s) 1-29 is/are pending in the application. 4a) Of the above claim(s) 11-23, 25, and 27 is/a 5) Claim(s) is/are allowed. 6) Claim(s) 1-29 is/are rejected. 7) Claim(s) is/are objected to. 8) Claim(s) are subject to restriction and/or	are withdrawn from consideration				
Application Papers					
9) The specification is objected to by the Examine	r.				
10)☐ The drawing(s) filed on is/are: a)☐ accepted or b)☐ objected to by the Examiner.					
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).					
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d). 11) The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.					
Priority under 35 U.S.C. § 119		v			
 12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f). a) All b) Some * c) None of: Certified copies of the priority documents have been received. Certified copies of the priority documents have been received in Application No Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)). * See the attached detailed Office action for a list of the certified copies not received. 					
Attachment(s) 1) ☑ Notice of References Cited (PTO-892) 2) ☐ Notice of Draftsperson's Patent Drawing Review (PTO-948) 3) ☑ Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08) Paper No(s)/Mail Date	4) Interview Summary Paper No(s)/Mail Da 5) Notice of Informal P 6) Other:				

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DETAILED ACTION

Election/Restrictions

Applicant's election with traverse of Group 1, claims 1-10, 24, 26, and 28-29 in the reply filed on 3/31/06 is acknowledged. The traversal is on the ground(s) that applicant does not agree with the grounds for the apparatus can practice another materially different process. The inventions are distinct and acquired a separate status in the art as shown by their different classification, restriction for examination purposes as indicated is proper. In response, a clarification on the reasons for distinctness is set forth. With respect to groups I and II, the process as claimed can be practiced with a materially different apparatus, such as a plasma etcher. With respect to groups I and III, the products claimed can be made by a materially different process such as, plasma etching a masked area to remove the substrate status in the grounds.

Claims 11-23, 25, and 27 are withdrawn from further consideration pursuant to 37 CFR 1.142(b), as being drawn to a nonelected group, there being no allowable generic or linking claim. Applicant timely traversed the restriction (election) requirement in the reply filed on 3/31/06.

The requirement is still deemed proper and is therefore made FINAL.

Claim Rejections - 35 USC § 102

The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

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(b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.

Claims 1-4, 6-10, 24, 26, and 28-29 are rejected under 35 U.S.C. 102(b) as being anticipated by Rizvi et al. (Direct manufacture of Miniature Bio-Particle Electromanipulator Devices using Excimer Laser Mask Projection Techniques; 1998; Exitech Limited, Long Hanborough, Oxford OX8 8Lh, UK) evidenced by Knowles et al. (Micromachining of Metals, Ceramics, Silicon and Polymers using Nanosecond Lasers) and Lumonics (Lumonics INDEX: Excimer Lasers for Industry).

Rizvi et al. anticipated a method for removing the edge region of a layer (see figure 1a) applied to a substrate (see fig. 1b) used in a microlithographic process (see fig. 2), by imaging a laser beam (see fig. 2) onto the layer applied to the substrate (see fig. 1b). Rizvi et al. teaches use of laser ablation for masked/unmasked removal of patterned areas on a substrate. Ablation implores evaporation, the method of applicants' limitation of claim 1. (See evidence of ablation imploring evaporation in the abstract of Micromachining of Metals, Ceramics, Silicon and Polymers using Nanosecond Lasers, by Knowles et al.)

As for claim 2, Rizvi et al. teaches the laser beam is focused in the form of a point, by imaging (see fig. 2).

As for claim 3, Rizvi et al. teaches the beam is imaged in a manner that is incident on the surface in an essentially perpendicular direction (see fig. 1a).

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As for claim 4, Rizvi et al. teaches the laser beam is incident on the plane spanned by the substrate that is in a tangential direction which is substantially parallel (see fig. 2).

As for claim 6, Rizvi et al. teaches the layer comprises a coating of polyimide (see page 4, second column, paragraph stating with "Having..."), a known photoresist, on multilevel thin film devices (see abstract) which are commonly known to be manufacture on wafers which are round.

As for claim 7, Rizvi et al. teaches the substrate and laser are moved relative to each other, while the laser scans the region (see fig. 2).

As for claim 8, Rizvi et al. teaches the region is optically scanned to adapt and regulate the removal of the desired area (see fig. 2).

As for claim 9, Rizvi et al. teaches an projection lens (i.e. aperature) which prevents the laser from imaging regions other than the desired region (see fig. 2).

As for claim 10, see discussion toward claim1 above.

As for claim 24, Rizvi et al. teaches the laser beam is focused in the form of a line (see fig. 1a).

As for claims 26 and 28, Rizvi et al. teaches the beam is focused by means of a projection lens (see page 2 line 7), which is cylindrical (see fig. 2).

As for claim 29, Rizvi et al. teaches use of a micromachining system which operates a 248nm KrF excitimer laser (see page two, column 2, paragraph 2). 248nm KrF excitimer lasers are rate by manufacturer having the average power normally in the range of 10 watts to 100 watts, which encompasses and overlaps applicants' claimed

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range. (see page 1, section "What is an Excimer Laser?", of Lumonics INDEX Excimer Lasers for industry, for evidence of said power rating.)

It is noted that the reference of Rizvi et al. is silent about the occurance of "evaporation". However, evaporation would inherently occur because the same step that is responsible for evaporation (i.e. ablation with laser bean) is occurring. The reference of Knowles et al. (Micromachining of Metals, Ceramics, Silicon and Polymers using Nanosecond Lasers) evidences the fact that laser ablation is known to cause evaporation. See the abstract of Knowles et al., where it is taught, it is usual for ablation to be a combination of evaporation.

Claim Rejections - 35 USC § 103

Claim 5 is rejected under 35 U.S.C. 103(a) as being unpatentable over Rizvi et al. as applied to claim1 above, and further in view of Quentel et al. (Multilevel diffractive optical element manufacture by excimer laser ablation and halftone masks), evidenced Lumonics (Lumonics, INDEX: Excimer Lasers for industry).

Rizvi et al. is silent as to the particles being removed by being blown or vacuumed from the region, as in claim 5.

Quentel et al. teaches reduction of particle redeposition by blowing air at the surface of the sample during ablation (see last sentence of section 3).

It would have been obvious to one of ordinary skill in the art at the time of invention was made, to include that air blown at the surface of the workpiece during ablation, as Quentel, when removing particles from the region of laser treatment, as in

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Rizvi et al., because Quentel et al. teaches doing so will reduce the particle redeposited on the surface (i.e. reduce particulate contamination), known to reduce defects.

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Patricia A. George whose telephone number is (571)272-5955. The examiner can normally be reached on weekdays between 7:00am and 4:30pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Nadine Norton can be reached on (571) 272-1465. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

Patricia A George Examiner Art Unit 1765

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